


Search Notes 	Application/Control No. 10035172	Applicant(s)/Patent Under Reexamination HUNTER ET AL.
	Examiner Hoang-Vu A Nguyen-Ba	Art Unit 2421

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East Search - USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	4/24/07	HAN
East Search - USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	7/23/08 & 7/24/08	HAN
IEEE Search	7/24/08	HAN
Farzana Hossein consulted for possible transfer	2007	HAN
725/32, 36, 22, 40-42, 46, 47, 58, 61 -- text search only	1/19/09	HAN
East Text Search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	8/12/09	HAN

INTERFERENCE SEARCH			
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